

Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 123456	APPLICATION NO. New U.S. National Stage of PCT/JP03/015635 <b>107537119</b>	
INFORMATION DISCLOSURE STATEMENT  (Use several sheets if necessary)				APPLICANTS Susumu NODA et al.		
				FILING DATE June 3, 2005	GROUP <b>2883</b>	
U.S. PATENT DOCUMENTS						
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
<i>Mpm</i>	1	US 2003/0234972 A1	12/25/03	SIMON		
FOREIGN PATENT DOCUMENTS						
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS
<i>Mpm</i>	2	WO 02/14913 A1	2/21/2002	WIPO		
	3	EP 1 136 853 A1	9/26/2001	EUROPE		
	4	JP A 06-82642 w/ abst & transl	3/25/1994	JAPAN		
	5	JP A 06-06490 w/ abst & transl	3/11/1994	JAPAN		
	6	JP A 2003-279764 w/ abst & transl	10/2/2003	JAPAN		
<i>Mpm</i>	7	JP 2001-272555w/ abst & transl	10/5/2001	JAPAN		
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)						
<i>Mpm</i>	8	IWAMOTO et al., "Functional Photonic Crystal Devices Using Micro-Electromechanical Systems," 2002 Nen Shuki Dai 63 Kai Extended Abstracts; <i>The Japan Society Of Applied Physics</i> , 26p-YA-8 MEMS o Ryo Shita Kinosei Photonic Kessho Shoshi, Hakko, Dai 3 Bunsatsu, pp. 922 {September 24, 2002}				
<i>Mpm</i>	9	TANAKA et al., "Improvement in Q Factor of Point Defect Cavity in SOI Based 2D Photonic Crystal Slab," 2003 Nen Shuki Dai 64 Kai Extended Abstracts; <i>The Japan Society of Applied Physics</i> , 1a-ZM-10, 2-Jigen Photonic Kessho Slab-Ten Kekkan Kyoshinkai heno 3-Jigen Kako no Koka-Rironkaiseki, Hakko, Dai 3 Bunsatsu, pp. 942 {August 30, 2003}				
<i>Mpm</i>						
EXAMINER	<i>Michael P. Mooney</i>				DATE CONSIDERED <i>8-28-07</i>	
Examiner:	Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.					



Sheet 1 of 1

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 123456	APPLICATION NO. 10/537,119	
INFORMATION DISCLOSURE STATEMENT  (Use several sheets if necessary)				APPLICANT(S) Susumu NODA et al.		
				FILING DATE June 3, 2005	GROUP 2883	
U.S. PATENT DOCUMENTS						
Examiner Initials	Cite No.	Document Number	Date	Name		
FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
<i>TM</i>	1	JP-A-2004-029810	01/29/2004	Japan	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
OTHER DOCUMENTS						
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)				
EXAMINER	<i>Michael P. Moony</i>					DATE CONSIDERED <i>8-28-07</i>
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